

Search Notes

Application/Control No.

10/752,642

Examiner

CHRIS C. CHU

Applicant(s)/Patent under
Reexamination

NAKAMURA ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	E21.584, E21.582 & E21.174	6/4/2008	C.C.
257	758 & 751	6/4/2008	C.C.
257	762 & 763	6/4/2008	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; and IBM_TDB;	6/4/2008	C.C.